## Application/Control No. Applicant(s)/Patent Under Reexamination 10/688,238 ELMADJIAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1765 Kin-Chan Chen **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 257/621 US-2005/0098855 05-2005 Shimoji et al. Α US-2004/0063268 438/202 04-2004 Noma et al. В US-6,864,172 С 03-2005 Noma et al. 438/674 US-6,873,054 03-2005 Miyazawa et al. 257/774 D Ε US-6,468,889 10-2002 lacoponi et al. 438/597 10-2002 257/774 F US-6,462,419 Asai, Shuji US-4,959,705 09-1990 Lemnios et al. 257/532 G 03-1995 438/232 US-5,395,799 Yu, Chen-Hua D. Н US-6,406,995 06-2002 Hussein et al. 438/638 1 216/64 J US-6,635,185 10-2003 Demmin et al. 252/79.1 US-6,649,082 11-2003 Hayasaka et al. Κ US-5,338,394 08-1994 Fathimulla et al. 438/718 L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date \* Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х